

**VNQ690SP**

QUAD CHANNEL HIGH SIDE SOLID STATE RELAY

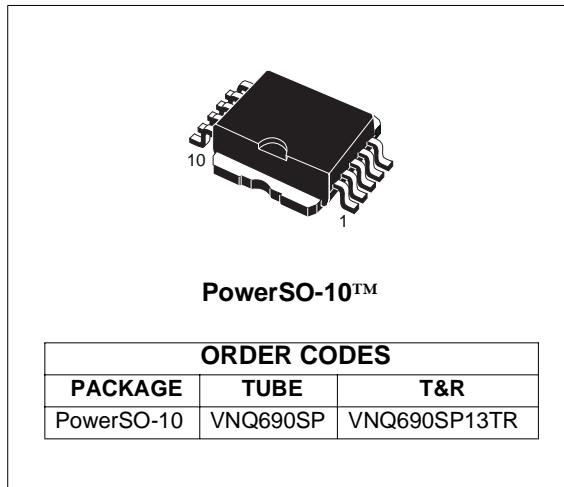
TYPE	R _{DS(on)}	I _{OUT}	V _{CC}
VNQ690SP	90mΩ (*)	10 A	36 V

(*) Per each channel

- OUTPUT CURRENT PER CHANNEL: 10A
- CMOS COMPATIBLE INPUTS
- OPEN LOAD DETECTION (OFF STATE)
- UNDervoltage & OVERVOLTAGE SHUT- DOWN
- OVERVOLTAGE CLAMP
- THERMAL SHUT-DOWN
- CURRENT LIMITATION
- VERY LOW STAND-BY POWER DISSIPATION
- PROTECTION AGAINST:
 - LOSS OF GROUND & LOSS OF V_{CC}
- REVERSE BATTERY PROTECTION (**)

DESCRIPTION

The VNQ690SP is a monolithic device made by using STMicroelectronics VIPower M0-3

**PowerSO-10™**

ORDER CODES		
PACKAGE	TUBE	T&R
PowerSO-10	VNQ690SP	VNQ690SP13TR

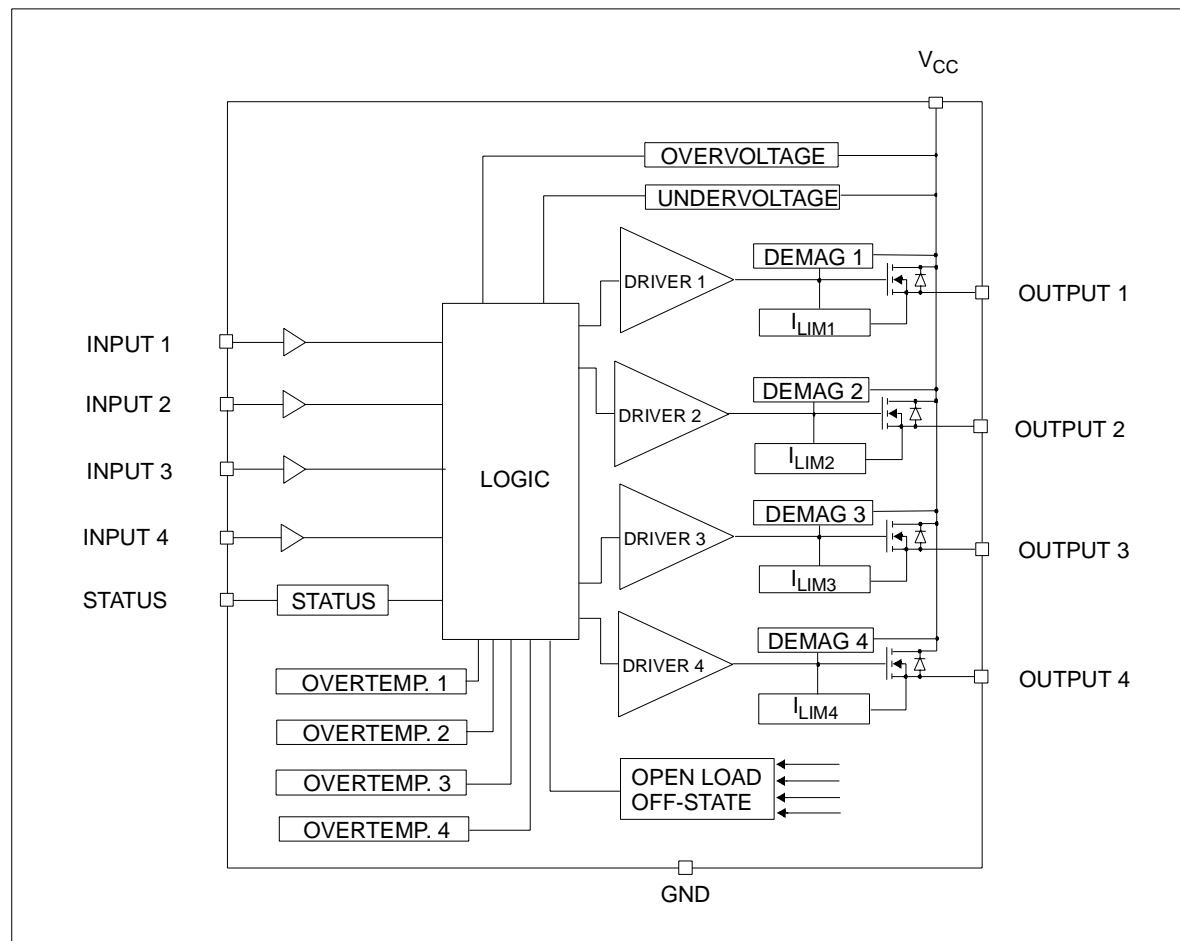
Technology, intended for driving resistive or inductive loads with one side connected to ground. This device has four independent channels. Built-in thermal shut down and output current limitation protect the chip from over temperature and short circuit.

ABSOLUTE MAXIMUM RATING

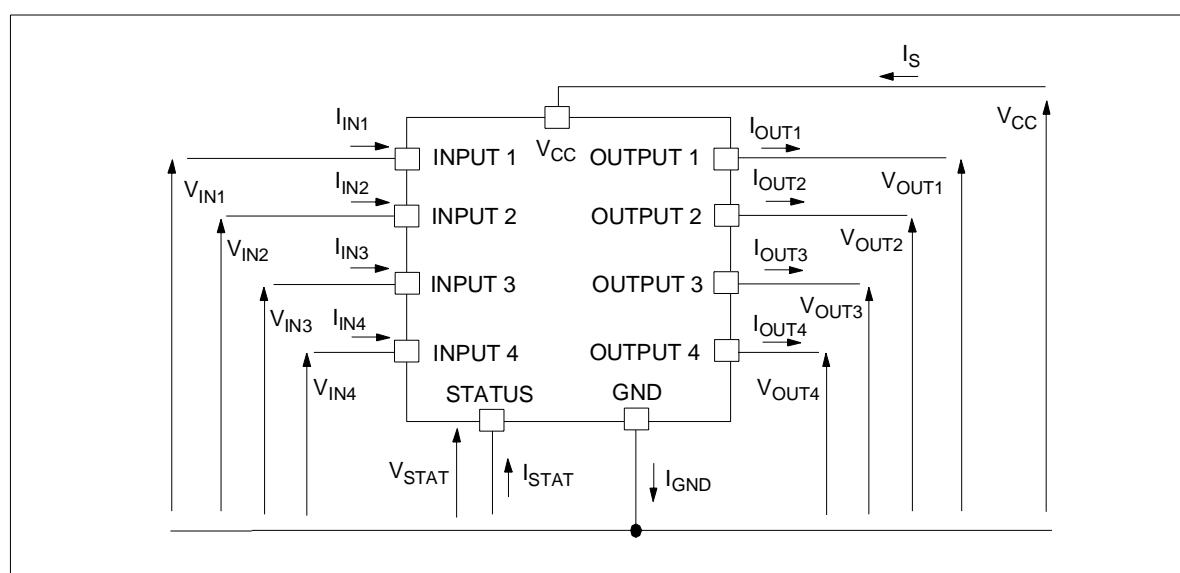
Symbol	Parameter	Value	Unit
V _{CC}	Supply voltage (continuous)	41	V
-V _{CC}	Reverse supply voltage (continuous)	-0.3	V
I _{OUT}	Output current (continuous), per each channel	Internally limited	A
I _R	Reverse output current (continuous), per each channel	-15	A
I _{IN}	Input current	+/- 10	mA
I _{STAT}	Status current	+/- 10	mA
I _{GND}	Ground current at T _C ≤25°C (continuous)	-200	mA
V _{ESD}	Electrostatic Discharge (Human Body Model: R=1.5KΩ; C=100pF)		
	- INPUT	4000	V
	- STATUS	4000	V
	- OUTPUT	5000	V
- V _{CC}	5000	V	
P _{tot}	Power dissipation at T _C =25°C	78	W
E _{MAX}	Maximum Switching Energy (L=0.38mH; R _L =0Ω; V _{bat} =13.5V; T _{jstart} =150°C; I _L =14A)	53	mJ
T _j	Junction operating temperature	-40 to 150	°C
T _{stg}	Storage temperature	-65 to 150	°C

(**) See application schematic at page 8

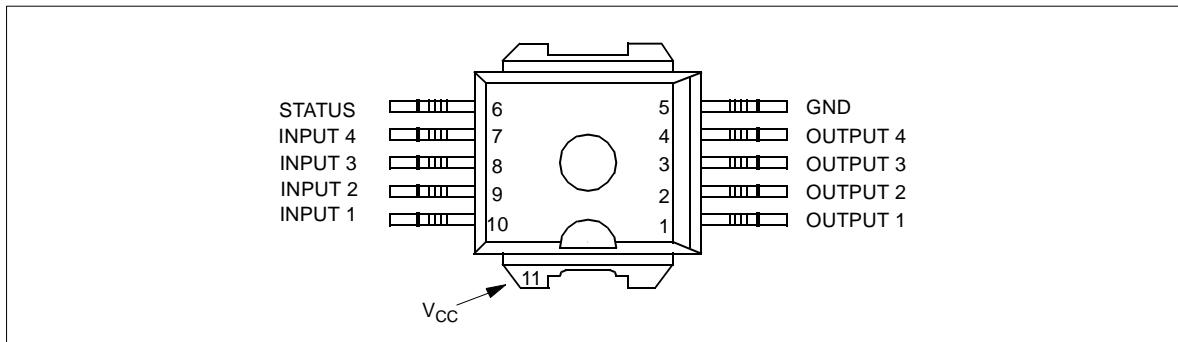
BLOCK DIAGRAM



CURRENT AND VOLTAGE CONVENTIONS



CONNECTION DIAGRAM (TOP VIEW)



THERMAL DATA

Symbol	Parameter	Value	Unit
$R_{thj-case}$	Thermal resistance junction-case (MAX) per channel	2	°C/W
R_{tj-amb}	Thermal resistance junction-ambient (MAX)	52 (***)	°C/W

(***) When mounted on a standard single-sided FR-4 board with 50 mm² of Cu (at least 35 µm thick).

ELECTRICAL CHARACTERISTICS ($V_{CC}=6V$ up to 24V; $-40^{\circ}C < T_j < 150^{\circ}C$ unless otherwise specified)
POWER (per each channel)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
V_{CC} (#)	Operating supply voltage		6	13	36	V
V_{USD} (#)	Undervoltage shutdown		3.5	4.6	6	V
V_{UVhyst} (#)	Undervoltage hysteresis		0.2		1	V
V_{OV} (#)	Oversupply shutdown		36			V
V_{OVhyst} (#)	Oversupply hysteresis		0.25			V
I_S (#)	Supply current	Off state; $V_{IN}=V_{OUT}=0V$; $V_{CC}=13.5V$		12	40	µA
		Off state; $V_{IN}=V_{OUT}=0V$; $V_{CC}=13.5V$		12	25	µA
		$T_j=25^{\circ}C$		6	12	mA
R_{ON}	On state resistance	$I_{OUT}=1A$; $T_j=25^{\circ}C$; $9V < V_{CC} < 18V$			90	mΩ
		$I_{OUT}=1A$, $T_j=150^{\circ}C$; $9V < V_{CC} < 18V$			180	mΩ
$I_{L(off1)}$	Off State Output Current	$V_{IN}=V_{OUT}=0V$	0		50	µA
$I_{L(off2)}$	Off State Output Current	$V_{IN}=0V$; $V_{OUT}=3.5V$	-75		0	µA
$I_{L(off3)}$	Off State Output Current	$V_{IN}=V_{OUT}=0V$; $V_{CC}=13V$; $T_j=125^{\circ}C$			5	µA
$I_{L(off4)}$	Off State Output Current	$V_{IN}=V_{OUT}=0V$; $V_{CC}=13V$; $T_j=25^{\circ}C$			3	µA

(#) Per device.

SWITCHING ($V_{CC}=13V$)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
$t_{d(on)}$	Turn-on delay time	$R_L=13\Omega$ channels 1,2,3,4		30		µs
$t_{d(off)}$	Turn-off delay time	$R_L=13\Omega$ channels 1,2,3,4		30		µs
$dV_{OUT}/dt_{(on)}$	Turn-on voltage slope	$R_L=13\Omega$ channels 1,2,3,4		See relative diagram		V/µs
$dV_{OUT}/dt_{(off)}$	Turn-off voltage slope	$R_L=13\Omega$ channels 1,2,3,4		See relative diagram		V/µs

VNQ690SP

ELECTRICAL CHARACTERISTICS (continued)

PROTECTIONS (per each channel)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
T_{TSD}	Shutdown temperature		150	170	200	°C
T_R	Reset temperature		135			°C
T_{hyst}	Thermal hysteresis		7	15	25	°C
I_{LIM}	DC Short circuit current	$9V < V_{CC} < 36V$ $6V < V_{CC} < 36V$	10	14	20	A
V_{demag}	Turn-off output voltage clamp	$I_{OUT}=2A$; $V_{IN}=0V$; $L=6mH$	$V_{CC}-41$	$V_{CC}-48$	$V_{CC}-55$	V
V_{STAT}	Status low output voltage	$I_{STAT}=1.6mA$			0.5	V
I_{LSTAT}	Status leakage current	Normal operation; $V_{STAT}=5V$			10	µA
C_{STAT}	Status pin input capacitance	Normal operation; $V_{STAT}=5V$			25	pF
V_{SCL}	Status clamp voltage	$I_{STAT}=1mA$ $I_{STAT}=-1mA$	6	6.8 -0.7	8	V V

LOGIC INPUT (per each channel)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
V_{IL}	Input Low Level Voltage				1.25	V
V_{IH}	Input High Level Voltage		3.25			V
V_{HYST}	Input Hysteresis Voltage		0.5			V
I_{IH}	Input high level voltage	$V_{IN}=3.25V$			10	µA
I_{IL}	Input Current	$V_{IN}=1.25V$	1			µA
V_{ICL}	Input Clamp Voltage	$I_{IN}=1mA$ $I_{IN}=-1mA$	6	6.8 -0.7	8	V V

OPENLOAD DETECTION (off state) per each channel

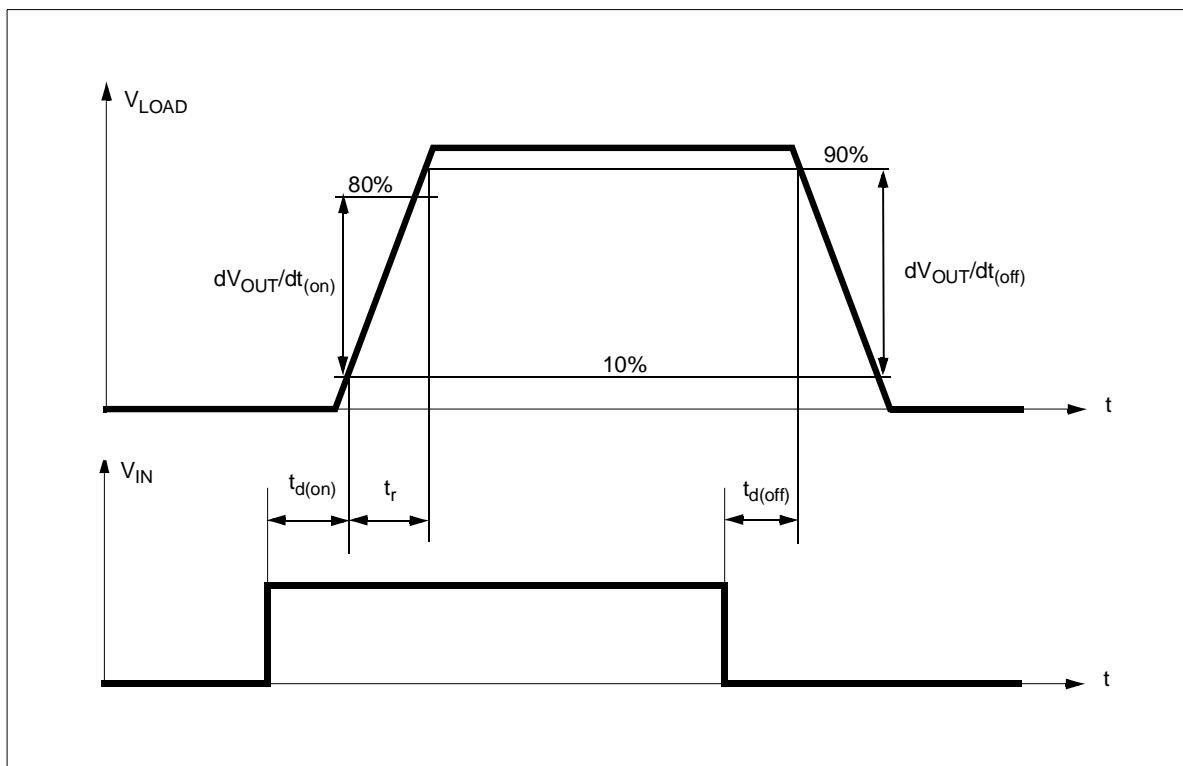
Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
t_{SDL}	Status Delay	See Figure 1 (Openload detection reading must be performed after T_{DOL}).			20	µs
V_{OL}	Openload Voltage Detection Threshold	$V_{IN}=0V$	1.5	2.5	3.5	V
T_{DOL}	Openload Detection Delay at Turn Off	$V_{CC}=18V$ (*)			300	µs

ELECTRICAL TRANSIENT REQUIREMENTS

ISO T/R 7637/1 Test Pulse	TEST LEVELS				
	I	II	III	IV	Delays and Impedance
1	-25 V	-50 V	-75 V	-100 V	2 ms 10 Ω
2	+25 V	+50 V	+75 V	+100 V	0.2 ms 10 Ω
3a	-25 V	-50 V	-100 V	-150 V	0.1 μs 50 Ω
3b	+25 V	+50 V	+75 V	+100 V	0.1 μs 50 Ω
4	-4 V	-5 V	-6 V	-7 V	100 ms, 0.01 Ω

ISO T/R 7637/1 Test Pulse	Test Levels Result			
	I	II	III	IV
1	C	C	C	C
2	C	C	C	C
3a	C	C	C	C
3b	C	C	C	C
4	C	C	C	C
5	C	E	E	E

Class	Contents
C	All functions of the device are performed as designed after exposure to disturbance.
E	One or more functions of the device is not performed as designed after exposure and cannot be returned to proper operation without replacing the device.

SWITCHING CHARACTERISTICS

VNQ690SP

TRUTH TABLE (per each channel)

CONDITIONS	INPUT	OUTPUT	STATUS
Normal Operation	L	L	H
	H	H	H
Overtemperature	L	L	H
	H	L	L
Undervoltage	L	L	X
	H	L	X
Overvoltage	L	L	H
	H	L	H
Current Limitation	L	L	H
	H	X	H
Output Voltage > V _{OL}	L	H	L
	H	H	H

Figure 1: Status timing waveforms

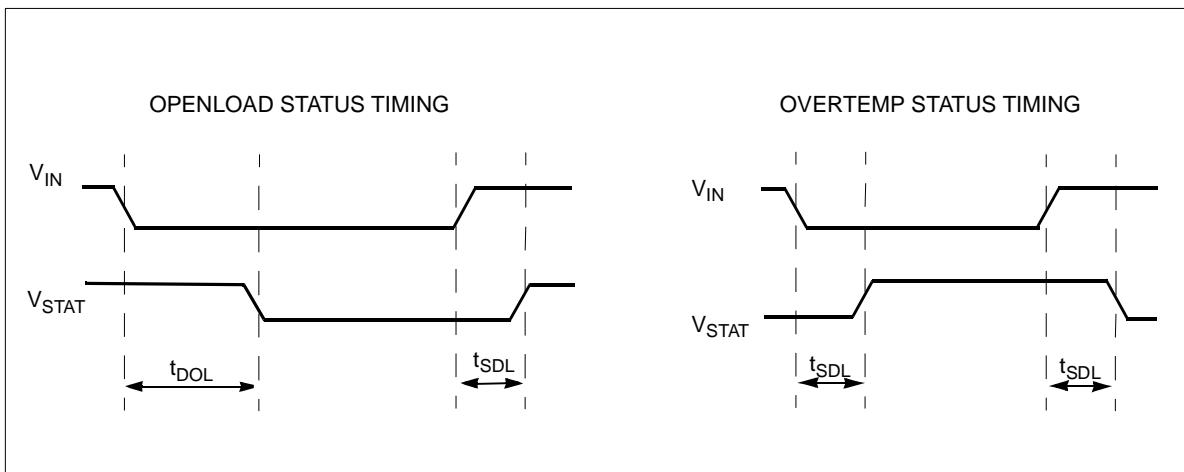
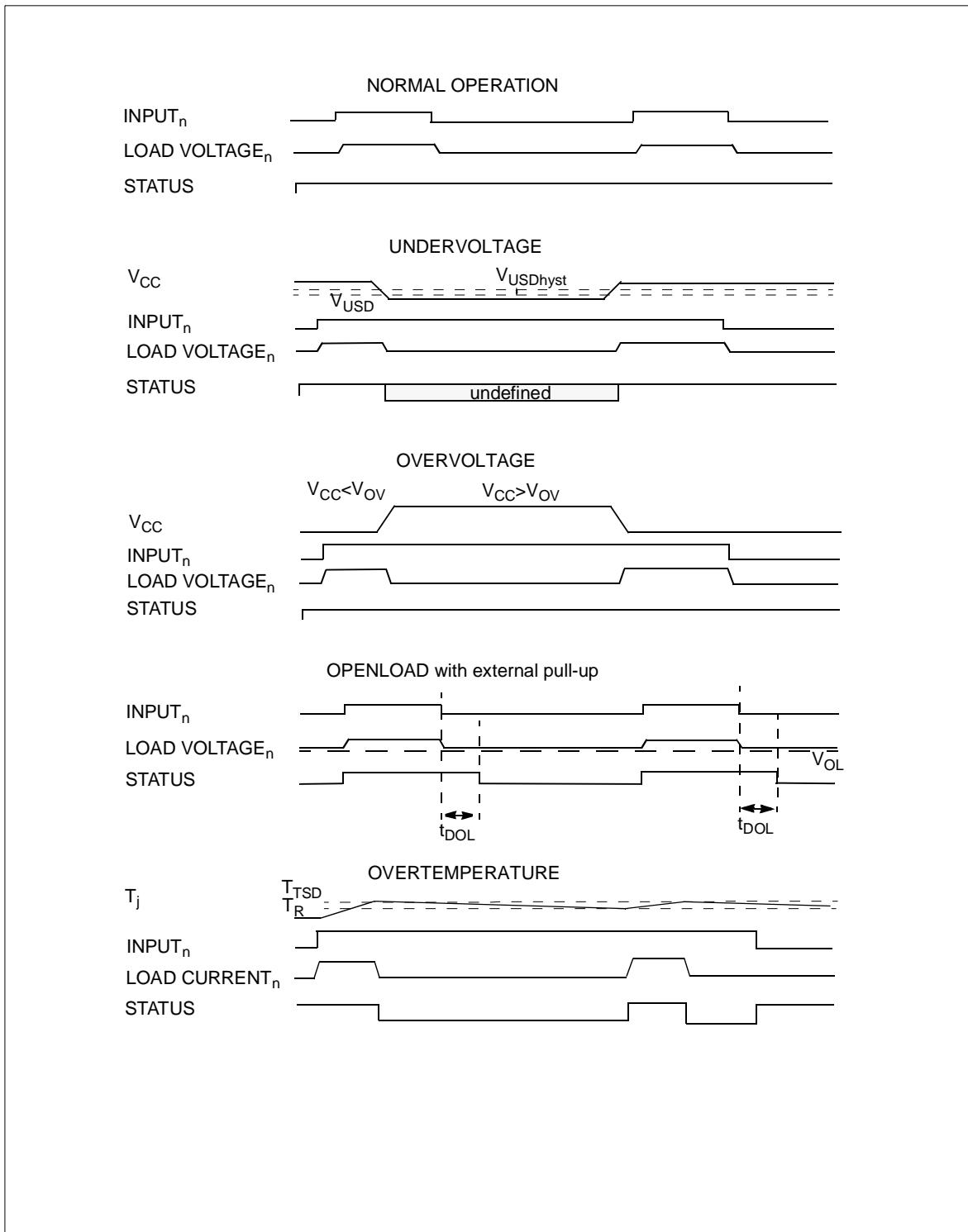
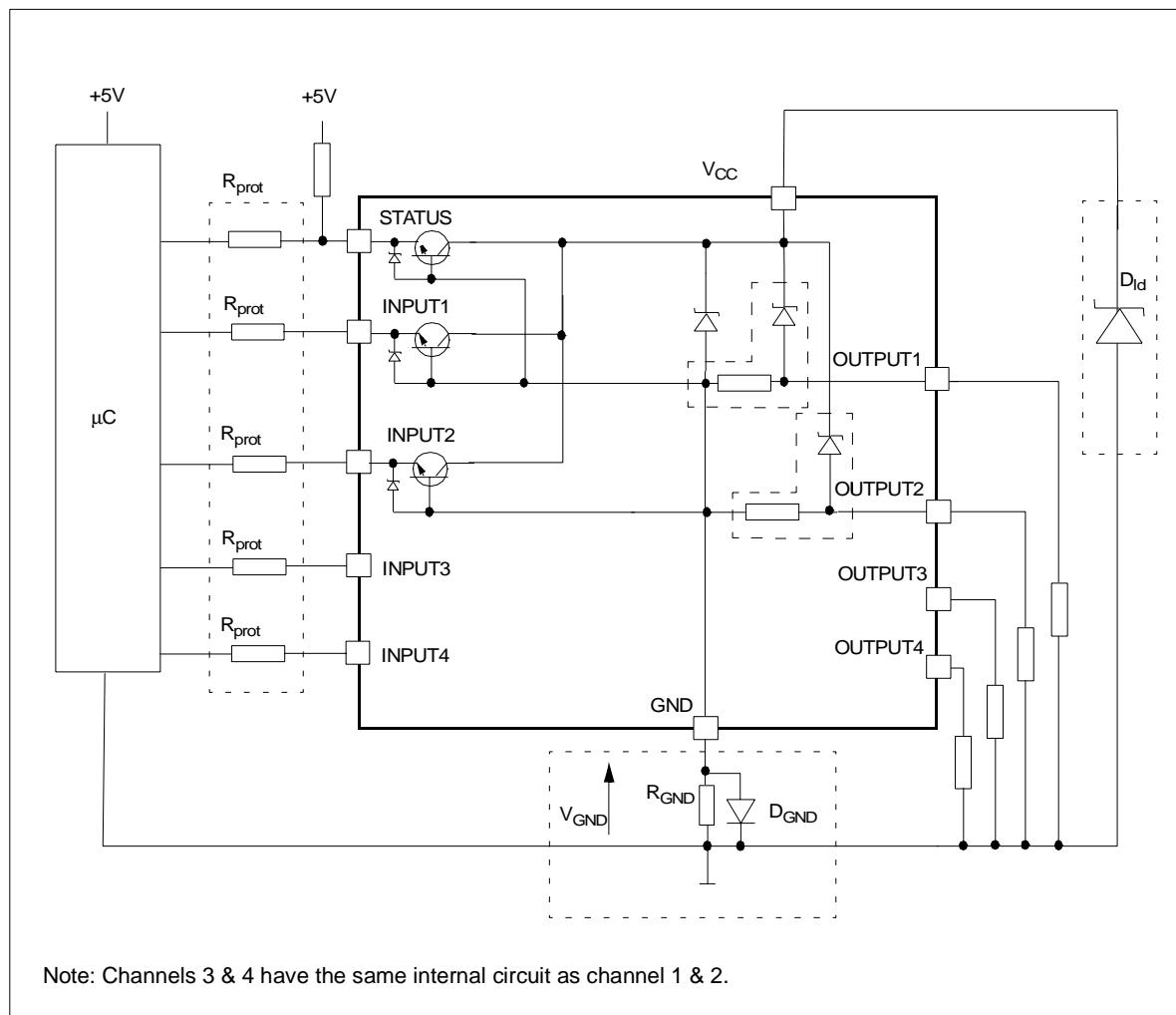


Figure 2: Waveforms

APPLICATION SCHEMATIC

**GND PROTECTION NETWORK AGAINST REVERSE BATTERY**

Solution 1: Resistor in the ground line (R_{GND} only). This can be used with any type of load.

The following is an indication on how to dimension the R_{GND} resistor.

- 1) $R_{GND} \leq 600\text{mV} / (I_{S(on)\max})$.
- 2) $R_{GND} \geq (-V_{CC}) / (-I_{GND})$

where $-I_{GND}$ is the DC reverse ground pin current and can be found in the absolute maximum rating section of the device's datasheet.

Power Dissipation in R_{GND} (when $V_{CC} < 0$: during reverse battery situations) is:

$$P_D = (-V_{CC})^2 / R_{GND}$$

This resistor can be shared amongst several different HSD. Please note that the value of this resistor should be calculated with formula (1) where $I_{S(on)\max}$ becomes the

sum of the maximum on-state currents of the different devices.

Please note that if the microprocessor ground is not common with the device ground then the R_{GND} will produce a shift ($I_{S(on)\max} * R_{GND}$) in the input thresholds and the status output values. This shift will vary depending on how many devices are ON in the case of several high side drivers sharing the same R_{GND} .

If the calculated power dissipation leads to a large resistor or several devices have to share the same resistor then the ST suggests to utilize Solution 2 (see below).

Solution 2: A diode (D_{GND}) in the ground line.

A resistor ($R_{GND}=1\text{k}\Omega$) should be inserted in parallel to D_{GND} if the device will be driving an inductive load.

This small signal diode can be safely shared amongst several different HSD. Also in this case, the presence of the ground network will produce a shift ($\approx 600\text{mV}$) in the input threshold and the status output values if the microprocessor ground is not common with the device

ground. This shift will not vary if more than one HSD shares the same diode/resistor network.

LOAD DUMP PROTECTION

D_{ld} is necessary (Voltage Transient Suppressor) if the load dump peak voltage exceeds V_{CC} max DC rating. The same applies if the device will be subject to transients on the V_{CC} line that are greater than the ones shown in the ISO T/R 7637/1 table.

μ C I/Os PROTECTION:

If a ground protection network is used and negative transient are present on the V_{CC} line, the control pins will be pulled negative. ST suggests to insert a resistor (R_{prot}) in line to prevent the μ C I/Os pins to latch-up.

The value of these resistors is a compromise between the leakage current of μ C and the current required by the HSD I/Os (Input levels compatibility) with the latch-up limit of μ C I/Os.

$$-V_{CCpeak}/I_{latchup} \leq R_{prot} \leq (V_{OH\mu C} - V_{IH} - V_{GND}) / I_{IHmax}$$

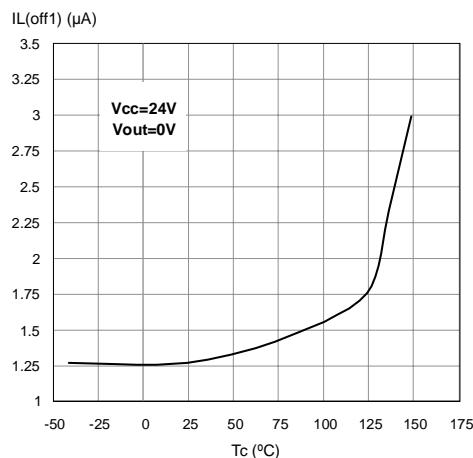
Calculation example:

For $V_{CCpeak} = -100V$ and $I_{latchup} \geq 20mA$; $V_{OH\mu C} \geq 4.5V$
 $5k\Omega \leq R_{prot} \leq 65k\Omega$.

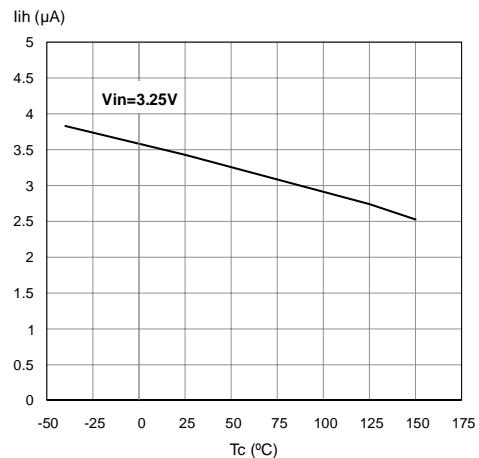
Recommended R_{prot} value is $10k\Omega$.

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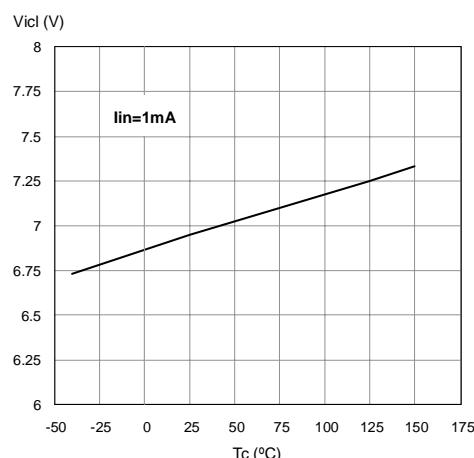
Off State Output Current



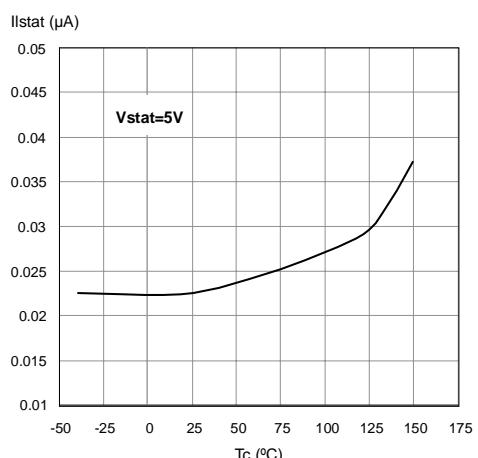
High Level Input Current



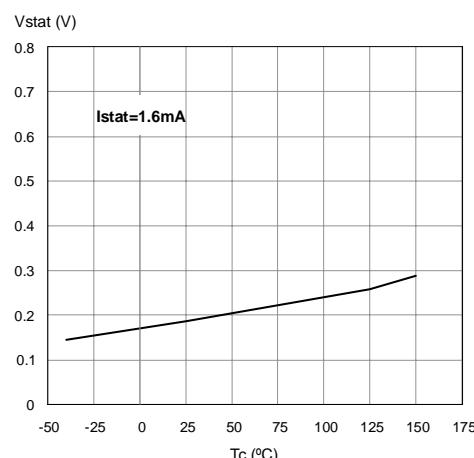
Input Clamp Voltage



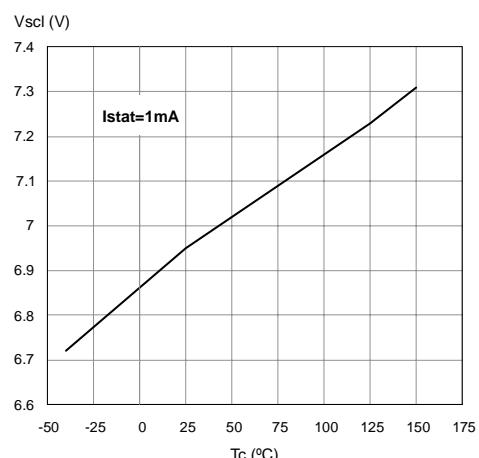
Status Leakage Current



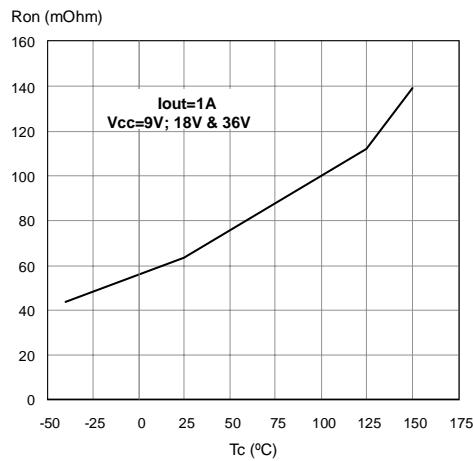
Status Low Output Voltage



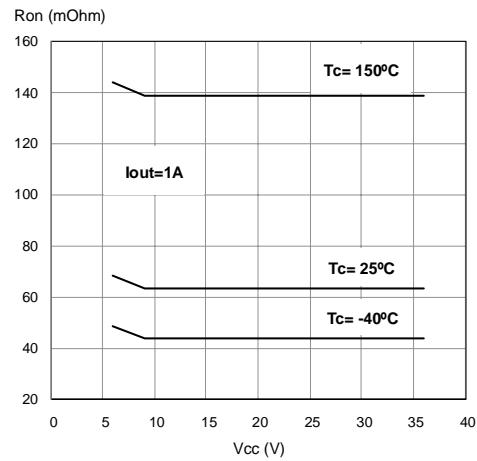
Status Clamp Voltage



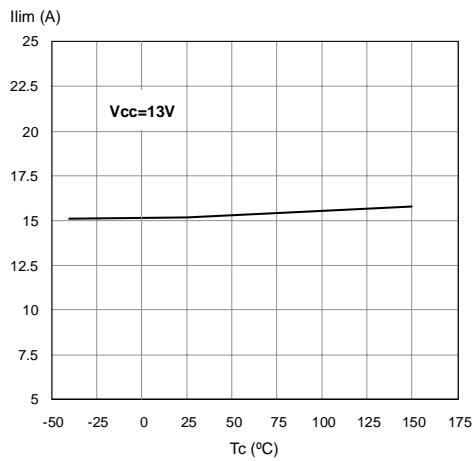
On State Resistance Vs T_{case}



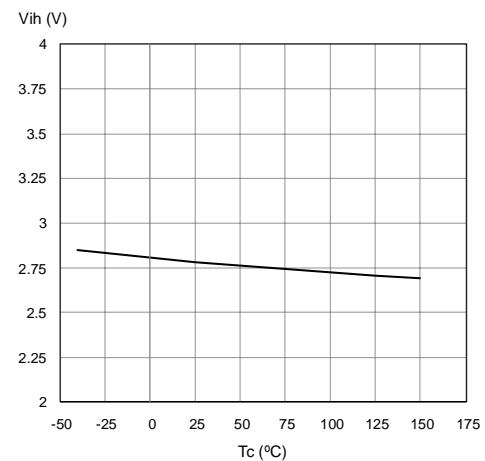
On State Resistance Vs Vcc



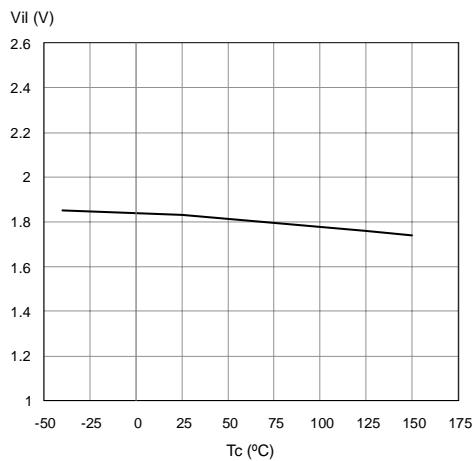
I_{LIM} Vs T_{case}



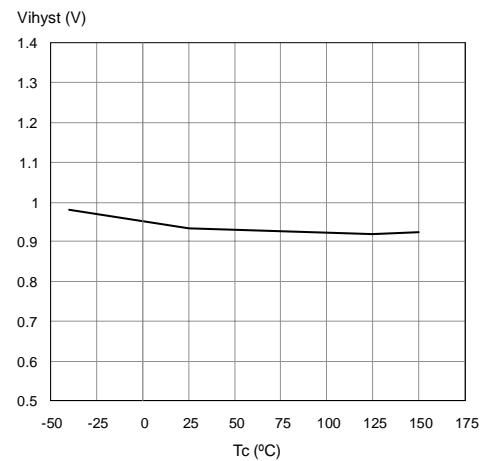
Input High Level



Input Low Level

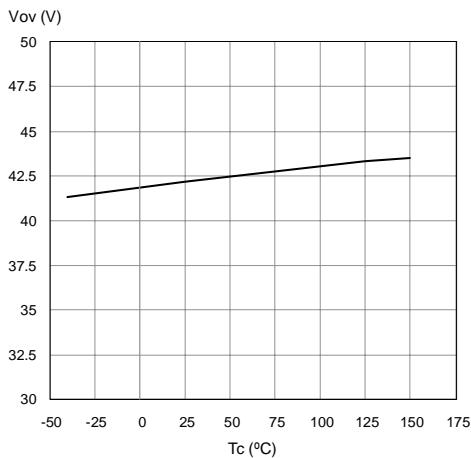


Input Hysteresis Voltage

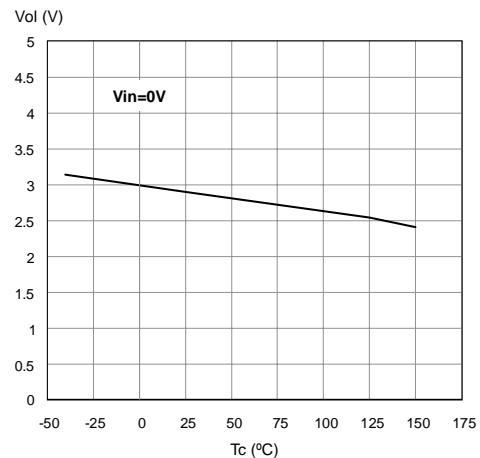


VNQ690SP

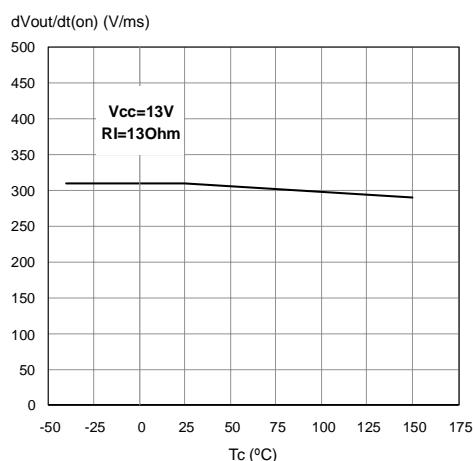
Overvoltage Shutdown



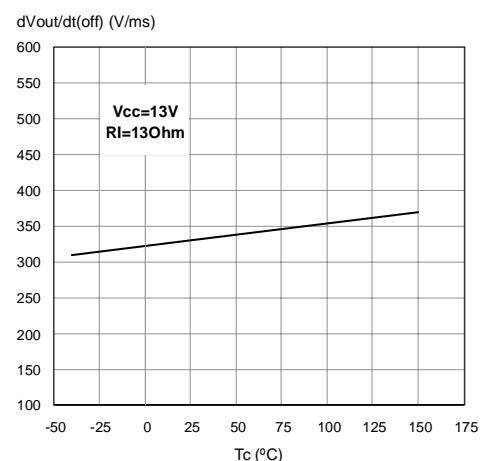
Openload Off State Voltage Detection Threshold

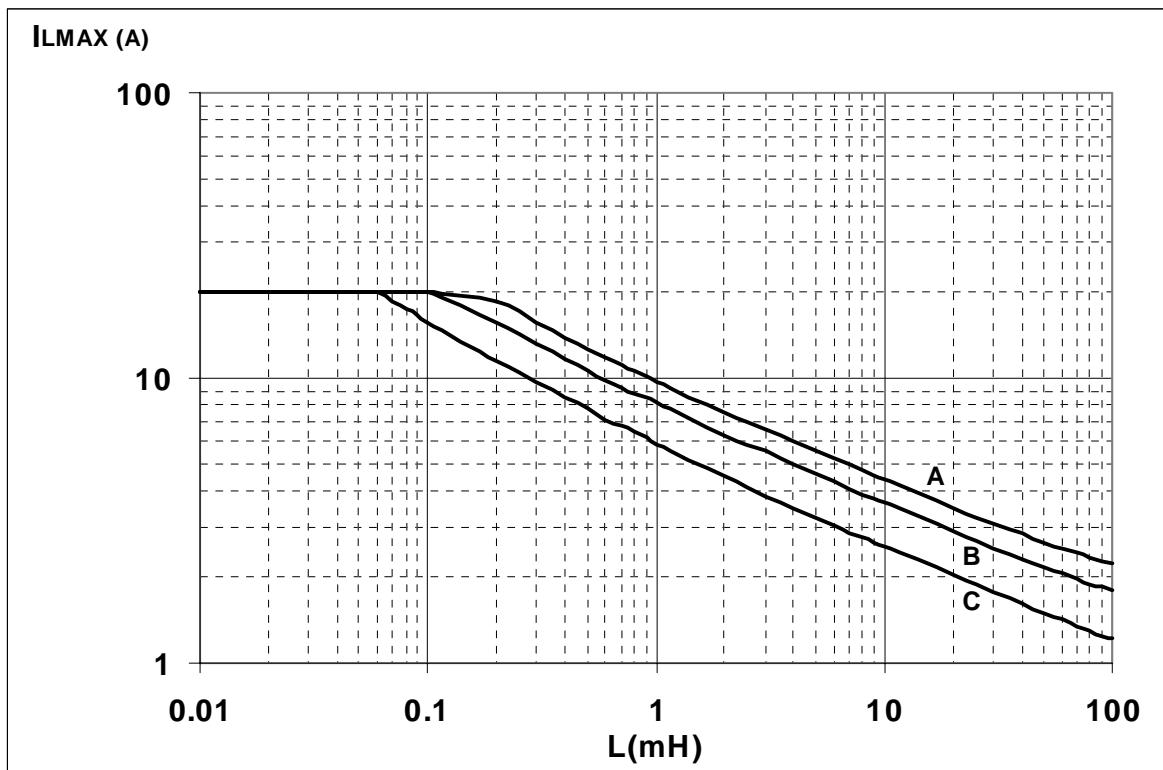
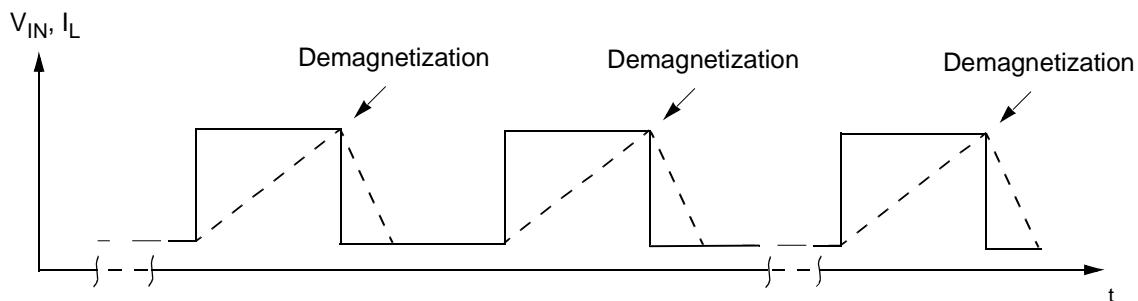


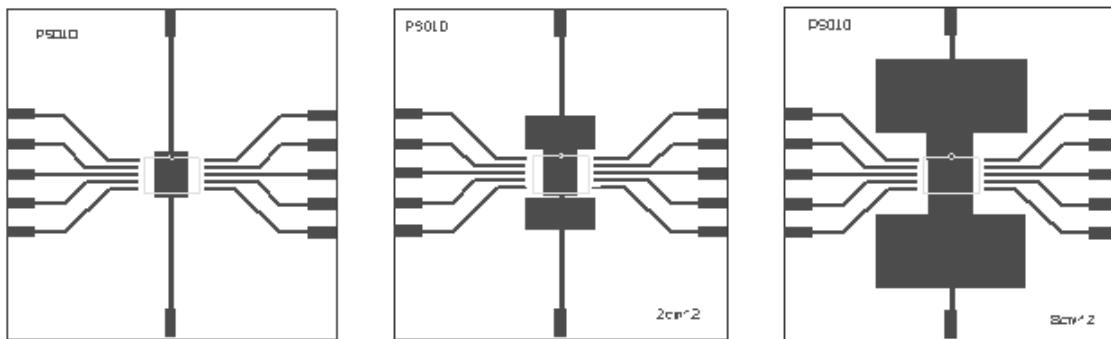
Turn-on Voltage Slope



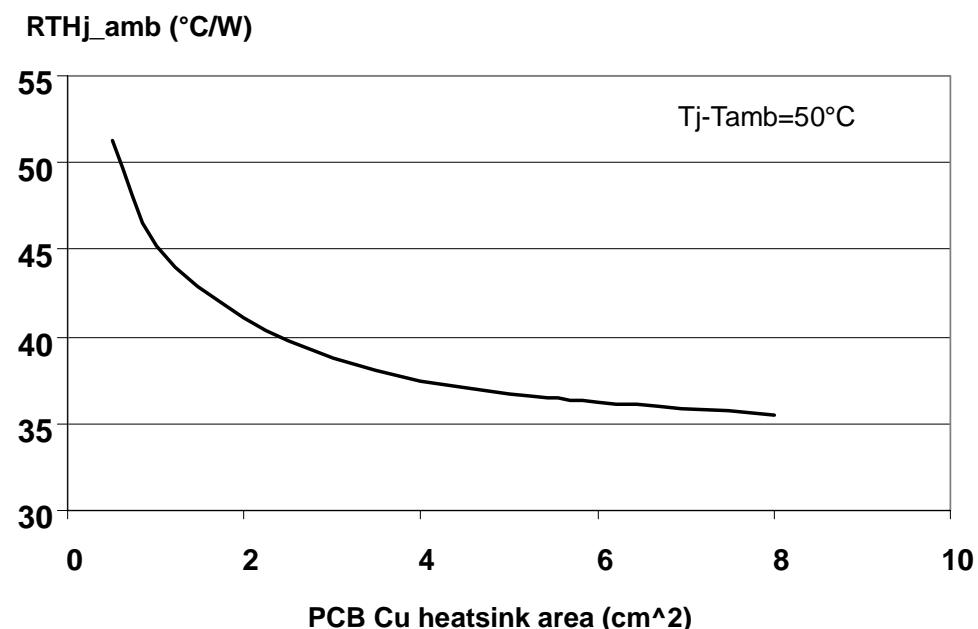
Turn-off Voltage Slope



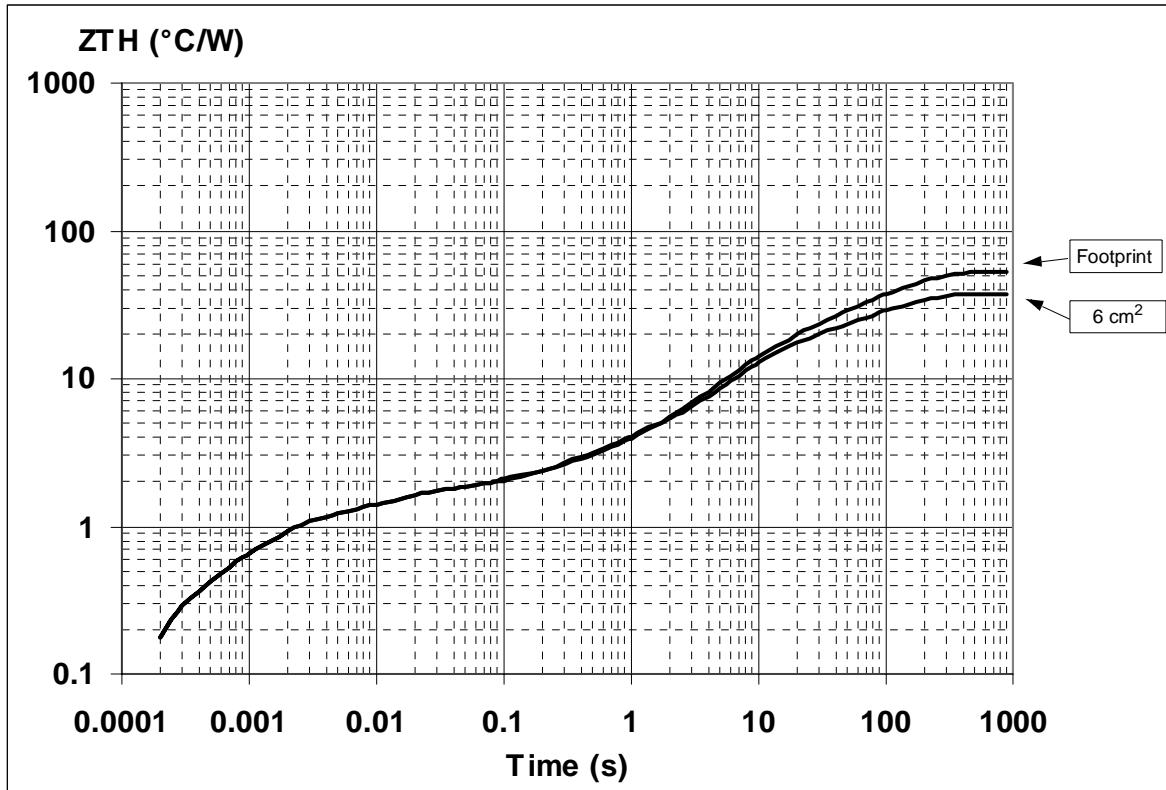
Maximum turn off current versus load inductanceA = Single Pulse at $T_{j\text{start}}=150^\circ\text{C}$ B= Repetitive pulse at $T_{j\text{start}}=100^\circ\text{C}$ C= Repetitive Pulse at $T_{j\text{start}}=125^\circ\text{C}$ Conditions: $V_{CC}=13.5\text{V}$ Values are generated with $R_L=0\Omega$ In case of repetitive pulses, $T_{j\text{start}}$ (at beginning of each demagnetization) of every pulse must not exceed the temperature specified above for curves B and C.

PowerSO-10™ THERMAL DATA**PowerSO-10™ PC Board**

Layout condition of R_{th} and Z_{th} measurements (PCB FR4 area= 58mm x 58mm, PCB thickness=2mm, Cu thickness=35 μ m, Copper areas: from minimum pad lay-out to 8cm 2).

 $R_{thj\text{-}amb}$ Vs PCB copper area in open box free air condition

Thermal Impedance Junction Ambient Single Pulse



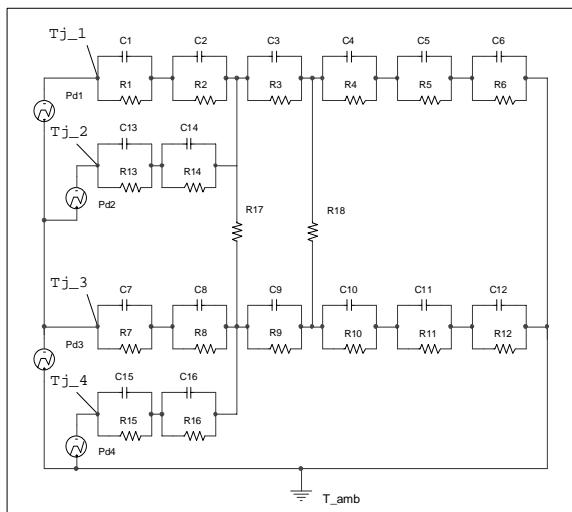
Thermal fitting model of a quad HSD in PowerSO-16

Pulse calculation formula

$$Z_{TH\delta} = R_{TH} \cdot \delta + Z_{THtp}(1 - \delta)$$

where $\delta = t_p/T$

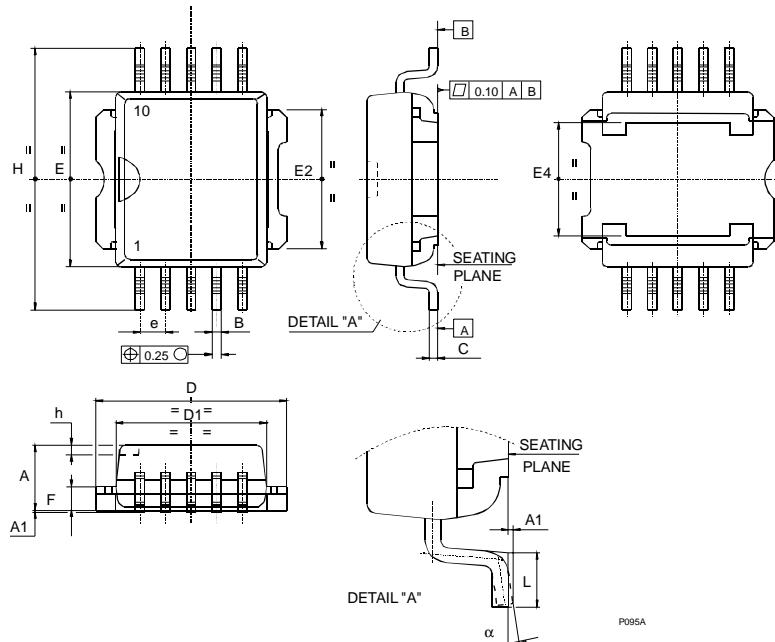
Thermal Parameter

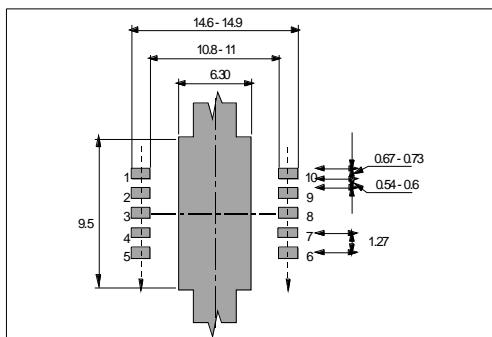
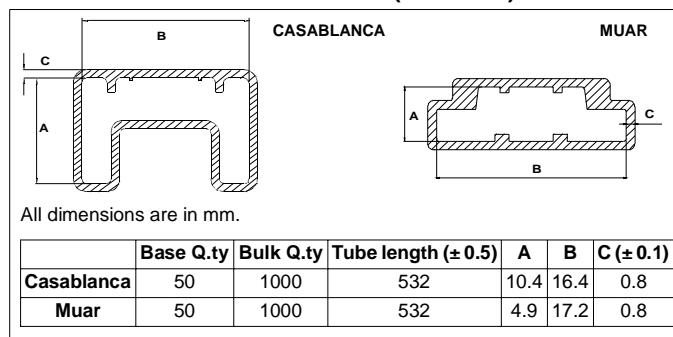
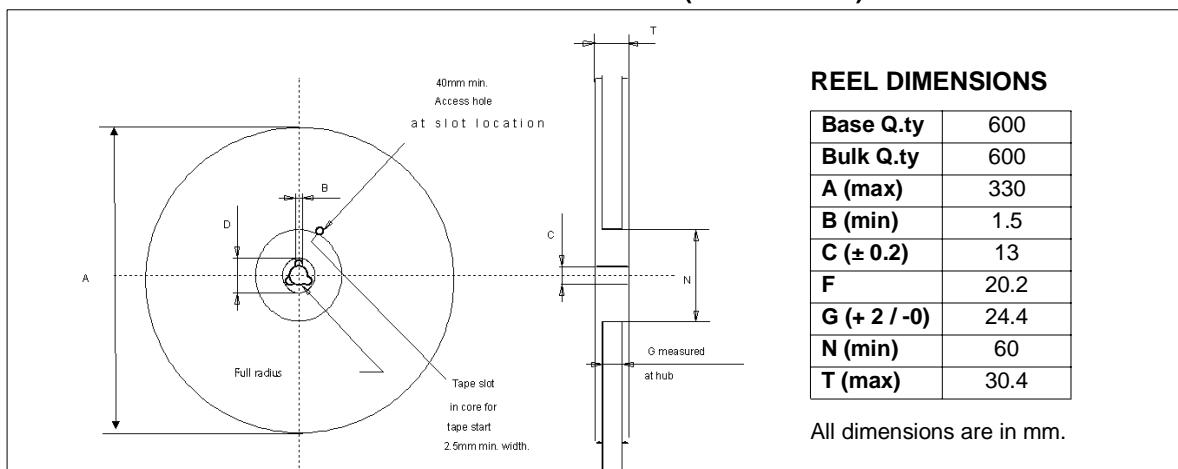


Area/island (cm^2)	Footprint	6
R1 ($^{\circ}\text{C}/\text{W}$)	0.18	
R2 ($^{\circ}\text{C}/\text{W}$)	0.8	
R3 ($^{\circ}\text{C}/\text{W}$)	0.7	
R4 ($^{\circ}\text{C}/\text{W}$)	0.8	
R5 ($^{\circ}\text{C}/\text{W}$)	13	
R6 ($^{\circ}\text{C}/\text{W}$)	37	22
C1 ($\text{W.s}/^{\circ}\text{C}$)	0.0006	
C2 ($\text{W.s}/^{\circ}\text{C}$)	1.50E-03	
C3 ($\text{W.s}/^{\circ}\text{C}$)	1.75E-02	
C4 ($\text{W.s}/^{\circ}\text{C}$)	0.4	
C5 ($\text{W.s}/^{\circ}\text{C}$)	0.75	
C6 ($\text{W.s}/^{\circ}\text{C}$)	3	5

PowerSO-10™ MECHANICAL DATA						
DIM.	mm.			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A	3.35		3.65	0.132		0.144
A (*)	3.4		3.6	0.134		0.142
A1	0.00		0.10	0.000		0.004
B	0.40		0.60	0.016		0.024
B (*)	0.37		0.53	0.014		0.021
C	0.35		0.55	0.013		0.022
C (*)	0.23		0.32	0.009		0.0126
D	9.40		9.60	0.370		0.378
D1	7.40		7.60	0.291		0.300
E	9.30		9.50	0.366		0.374
E2	7.20		7.60	0.283		0.300
E2 (*)	7.30		7.50	0.287		0.295
E4	5.90		6.10	0.232		0.240
E4 (*)	5.90		6.30	0.232		0.248
e		1.27			0.050	
F	1.25		1.35	0.049		0.053
F (*)	1.20		1.40	0.047		0.055
H	13.80		14.40	0.543		0.567
H (*)	13.85		14.35	0.545		0.565
h		0.50			0.002	
L	1.20		1.80	0.047		0.070
L (*)	0.80		1.10	0.031		0.043
α	0°		8°	0°		8°
α (*)	2°		8°	2°		8°

(*) Muar only POA P013P

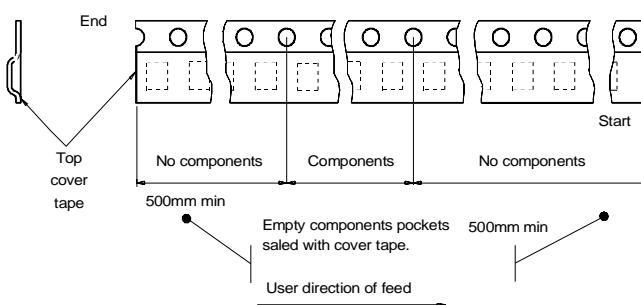
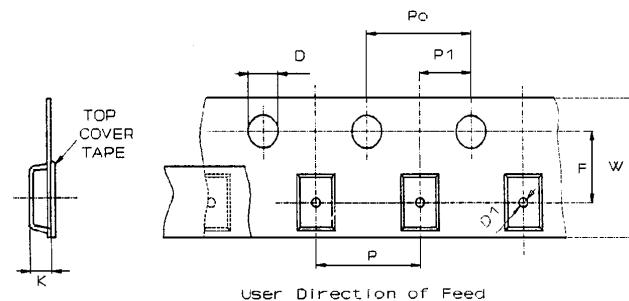


PowerSO-10™ SUGGESTED PAD LAYOUT**TUBE SHIPMENT (no suffix)****TAPE AND REEL SHIPMENT (suffix "13TR")****TAPE DIMENSIONS**

According to Electronic Industries Association (EIA) Standard 481 rev. A, Feb. 1986

Tape width	W	24
Tape Hole Spacing	P0 (± 0.1)	4
Component Spacing	P	24
Hole Diameter	D ($\pm 0.1/-0$)	1.5
Hole Diameter	D1 (min)	1.5
Hole Position	F (± 0.05)	11.5
Compartment Depth	K (max)	6.5
Hole Spacing	P1 (± 0.1)	2

All dimensions are in mm.



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